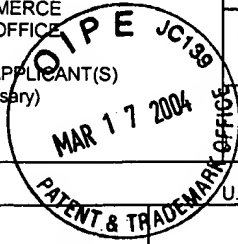


#7

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. 00862.021986.		APPLICATION NO. 09/645,318	
				APPLICANT Yuji Konno et al.			
				FILING DATE August 25, 2000		GROUP 2626	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TJL		5,162,925	11/10/92	Takaoka et al.	358	447	
TJL		4,533,928	08/06/85	Sugiura et al.	346	140 R	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
TJL		0 651 563 A1	05/03/95	EPO	H04N	1/64	English
TJL		0 482 848 A2	04/29/92	EPO	H04N	1/41	English
<div style="border: 1px solid black; padding: 5px; display: inline-block;"> RECEIVED MAR 18 2004 </div>							
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		Technology Center 2600					
EXAMINER				DATE CONSIDERED 9/21/04			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

#4

FORM PTO 1449 (modified)				ATTY DOCKET NO. 862.C1986		APPLICATION NO. 09/645,318	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANT YUJI KONNO ET AL.			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				FILING DATE August 25, 2000		GROUP Not yet known	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TJL		5,115,241	05/19/92	Ishikawa	341	143	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED	9/20/04		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.